

CA-IS376x High-Speed Six-Channel Digital Isolators

1. Features

- **Robust Galvanic Isolation of Digital Signals**
 - High lifetime: >40 years
 - Up to 5000 V_{RMS} isolation rating (narrow body packages) and up to 5000 V_{RMS} isolation rating (wide body packages)
 - ±150 kV/μs typical CMTI
 - Wide operating temperature range: -40°C to 125°C
 - Schmitt trigger inputs
- **Interfaces Directly with Most MCUs and FPGAs**
 - Data rate: DC to 150Mbps
 - Accepts 2.5V to 5.5V supplies
 - Default output *High* (CA-IS376xH) and *Low* (CA-IS376xL) Options
- **Low Power Consumption**
 - 1.5mA per channel at 1Mbps with V_{DD} = 5.0V
 - 6.6mA per channel at 100Mbps with V_{DD} = 5.0V
- **Best in class propagation delay and skew**
 - 12ns typical propagation delay
 - 1ns pulse width distortion
 - 2ns propagation delay skew (chip -to-chip)
 - 5ns minimum pulse width
- **No Start-Up Initialization Required**
- **Package Options**
 - Narrow-body SOIC16-NB(N) package
 - Wide-body SOIC16-WB(W) package
- **Safety Regulatory Approvals**
 - VDE 0884-17 isolation certification
 - UL According to UL1577
 - IEC 62368-1, IEC 61010-1, GB 4943.1-2011 and GB 8898-2011 certifications

2. Applications

- Industrial Automation
- Motor Control
- Medical Systems
- Isolated Power Supplies
- Solar Inverters
- Isolated ADC,DAC

3. General Description

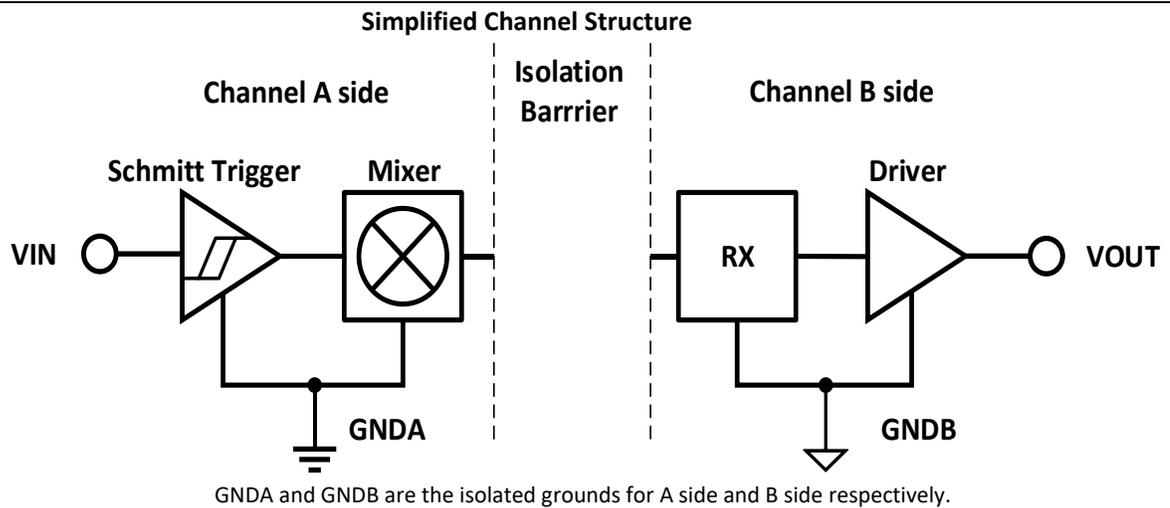
The CA-IS376x devices are high-performance six-channel, unidirectional digital isolators with up to 3.75kV_{RMS} (narrow-body package) or 5kV_{RMS} (wide-body package) isolation rating and ultra-fast data rate. The CA-IS376x devices offer high electromagnetic immunity and low emissions at low power consumption while isolating different ground domains and block high-voltage/high-current transients from sensitive or human interface circuitry. Each isolation channel has a logic input and output buffer separated by capacitive silicon dioxide (SiO₂) insulation barrier, the integrated Schmitt trigger on each input provide excellent noise immunity.

The CA-IS376x family offers all possible unidirectional channel configurations to accommodate any 6-channel design digital I/O applications, especial for the multiple SPI devices isolation. The CA-IS3760 features six channels transferring digital signals in one direction; The CA-IS3761 device has five forward and one reverse-direction channels; The CA-IS3762 device offers four forward and two reverse-direction channels isolation; The CA-IS3763 provides further design flexibility with three channels in each direction. All devices of this family features default outputs. When the input is either not powered or is open-circuit, the default output is low for devices with suffix L and high for devices with suffix H, see the *Ordering Information* for suffixes associated with each option.

The CA-IS376x series devices are specified over the -40°C to +125°C operating temperature range and are available in 16-pin SOIC narrow body package and 16-pin SOIC wide body package.

Device information

| Part number | Package | Package size (NOM) |
|-------------|---------------|--------------------|
| CA-IS3760 | SOIC16-NB (N) | 9.90 mm × 3.90 mm |
| CA-IS3761 | | |
| CA-IS3762 | SOIC16-WB(W) | 10.30 mm × 7.50 mm |
| CA-IS3763 | | |



4. Ordering Information

Table 4-1. Ordering Information

| Part Number | Number of Inputs A Side | Number of Inputs B Side | Default Output | Isolation Rating (Kv_{Rms}) | Output Enable | Package |
|-------------|-------------------------|-------------------------|----------------|---------------------------------|---------------|-----------|
| CA-IS3760LN | 6 | 0 | Low | 3.75 | No | SOIC16-NB |
| CA-IS3760LW | 6 | 0 | Low | 5.0 | No | SOIC16-WB |
| CA-IS3760HN | 6 | 0 | High | 3.75 | No | SOIC16-NB |
| CA-IS3760HW | 6 | 0 | High | 5.0 | No | SOIC16-WB |
| CA-IS3761LN | 5 | 1 | Low | 3.75 | No | SOIC16-NB |
| CA-IS3761LW | 5 | 1 | Low | 5.0 | No | SOIC16-WB |
| CA-IS3761HN | 5 | 1 | High | 3.75 | No | SOIC16-NB |
| CA-IS3761HW | 5 | 1 | High | 5.0 | No | SOIC16-WB |
| CA-IS3762LN | 4 | 2 | Low | 3.75 | No | SOIC16-NB |
| CA-IS3762LW | 4 | 2 | Low | 5.0 | No | SOIC16-WB |
| CA-IS3762HN | 4 | 2 | High | 3.75 | No | SOIC16-NB |
| CA-IS3762HW | 4 | 2 | High | 5.0 | No | SOIC16-WB |
| CA-IS3763LN | 3 | 3 | Low | 3.75 | No | SOIC16-NB |
| CA-IS3763LW | 3 | 3 | Low | 5.0 | No | SOIC16-WB |
| CA-IS3763HN | 3 | 3 | High | 3.75 | No | SOIC16-NB |
| CA-IS3763HW | 3 | 3 | High | 5.0 | No | SOIC16-WB |

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5. Revision History

| Revision Number | Description | Revision date | Page Changed |
|-----------------|--|---------------|---------------|
| Version 1.0 | N/A | | N/A |
| Version 1.01 | Changed V_{IORM} to 1414V, changed V_{IOWM} AC RMS value to 1000V and DC value to 1414V. Updated Power Ratings table. | | 7, 11, 12, 13 |
| Version 1.02 | $V_{IT+(IN)}$ min value updated to 2V, $V_{IT-(IN)}$ max value updated to 0.8V and removed $V_{I(HYS)}$. | | 9 |
| Version 1.03 | Description of $V_{IT+(IN)}$ changed to High-level Input Voltage, description of $V_{IT-(IN)}$ changed to Low-level Input Voltage. | | 9 |
| Version 1.04 | Revised POD and tape reel information | 2022/12/15 | 19,22 |
| Version 1.05 | Update VDE certification information Update Supply Current information | 2023/09/13 | 7,8 10-12 |

6. Pin Configuration and Description

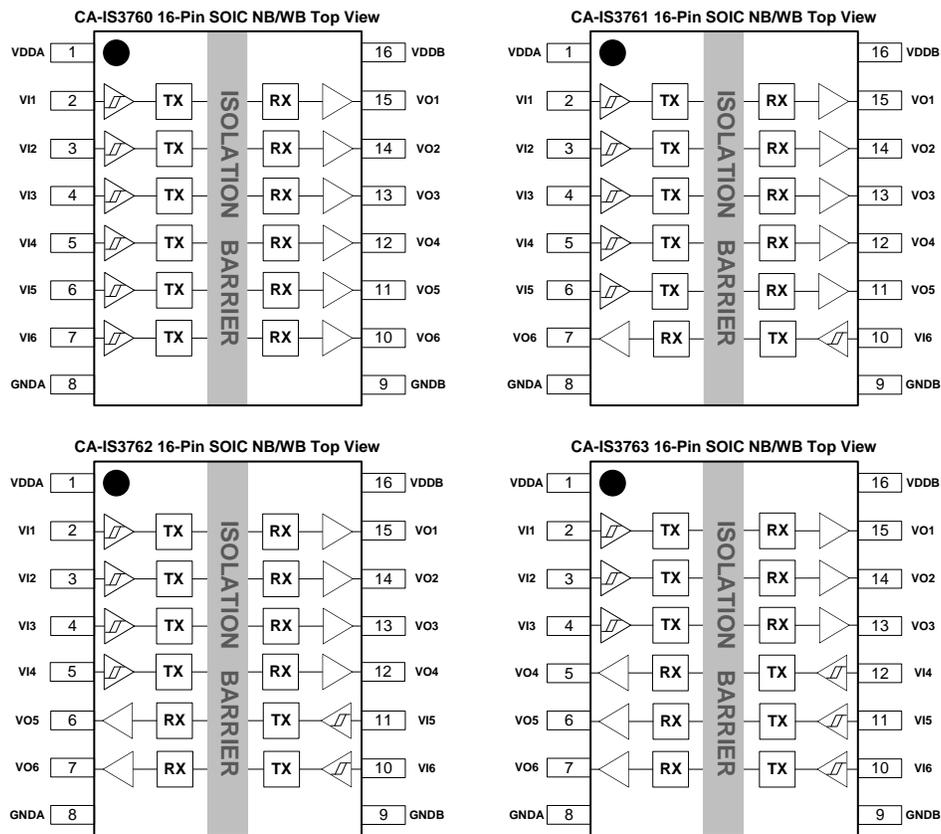


Figure 6-1. CA-IS376x pin configuration

Table 6-1. CA-IS376x pin description

| 16-SOIC Pin# | | | | Name | Type | Description |
|--------------|-----------|-----------|-----------|------|-------------|--|
| CA-IS3760 | CA-IS3761 | CA-IS3762 | CA-IS3763 | | | |
| 1 | 1 | 1 | 1 | VDDA | Supply | Power supply for side A. |
| 2 | 2 | 2 | 2 | VI1 | Digital I/O | Digital input 1 on side A, corresponds to logic output 1 on side B. |
| 3 | 3 | 3 | 3 | VI2 | Digital I/O | Digital input 2 on side A, corresponds to logic output 2 on side B. |
| 4 | 4 | 4 | 4 | VI3 | Digital I/O | Digital input 3 on side A, corresponds to logic output 3 on side B. |
| 5 | 5 | 5 | 12 | VI4 | Digital I/O | Digital input 4 on side A/B, corresponds to logic output 4 on side B/A. |
| 6 | 6 | 11 | 11 | VI5 | Digital I/O | Digital input 5 on side A/B, corresponds to logic output 5 on side B/A. |
| 7 | 10 | 10 | 10 | VI6 | Digital I/O | Digital input 6 on side A/B, corresponds to logic output 6 on side B/A. |
| 8 | 8 | 8 | 8 | GNDA | Ground | Ground reference for side A. |
| 9 | 9 | 9 | 9 | GNDB | Ground | Ground reference for side B. |
| 10 | 7 | 7 | 7 | VO6 | Digital I/O | Digital output 6 on side B/A, VO6 is the logic output for the VI6 input on side A/B. |
| 11 | 11 | 6 | 6 | VO5 | Digital I/O | Digital output 5 on side B/A, VO5 is the logic output for the VI5 input on side A/B. |
| 12 | 12 | 12 | 5 | VO4 | Digital I/O | Digital output 4 on side B/A, VO4 is the logic output for the VI4 input on side A/B. |
| 13 | 13 | 13 | 13 | VO3 | Digital I/O | Digital output 3 on side B, VO3 is the logic output for the VI3 input on side A. |
| 14 | 14 | 14 | 14 | VO2 | Digital I/O | Digital output 2 on side B, VO2 is the logic output for the VI2 input on side A. |
| 15 | 15 | 15 | 15 | VO1 | Digital I/O | Digital output 1 on side B, VO1 is the logic output for the VI1 input on side A. |
| 16 | 16 | 16 | 16 | VDDB | Supply | Power supply for side B. |

7. Specifications

7.1. Absolute Maximum Ratings¹

| Parameters | | Minimum value | Maximum value | Unit |
|-------------------------------------|--|---------------|-------------------------------------|------|
| V _{DDA} , V _{DDB} | Power supply voltage ² | -0.5 | 7.0 | V |
| V _{IN} | Voltage at V _{Ix} , V _{Ox} , EN _x | -0.5 | V _{DD_} + 0.5 ³ | V |
| I _O | Output current | -20 | 20 | mA |
| T _J | Junction temperature | | 150 | °C |
| T _{STG} | Storage temperature range | -65 | 150 | °C |

Notes:

- The stresses listed under “Absolute Maximum Ratings” are stress ratings only, not for functional operation condition. Exposure to absolute maximum rating conditions for extended periods may cause permanent damage to the device.
- All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GNDA or GNDB) and are peak voltage values.
- Maximum voltage must not be exceed 7 V.

7.2. ESD Ratings

| | | Numerical value | Unit |
|---|--|-----------------|------|
| V _{ESD} Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ¹ | ±6000 | V |
| | Charged device model (CDM), per JEDEC Specification JESD22-C101, all pins ² | ±2000 | |

Notes:

- Per JEDEC document JEP155, 500V HBM allows safe manufacturing of standard ESD control process.
- Per JEDEC document JEP157, 250V HBM allows safe manufacturing of standard ESD control process.

7.3. Recommended Operating Conditions

| PARAMETER | | MIN | TYPE | MAX | UNIT |
|-------------------------------------|--|------------------------------------|------|-------|------|
| V _{DDA} , V _{DDB} | Supply voltage on side A, B | 2.375 | 3.30 | 5.50 | V |
| V _{DD(UVLO+)} | V _{DD} Under-voltage-Lockout Threshold When Supply Voltage is Rising | 1.95 | 2.24 | 2.375 | V |
| V _{DD(UVLO-)} | V _{DD} Under-voltage-Lockout Threshold When Supply Voltage is Falling | 1.88 | 2.10 | 2.325 | V |
| V _{HYS(UVLO)} | V _{DD} Under-voltage-Lockout Threshold Hysteresis | 70 | 140 | 250 | mV |
| I _{OH} | High-level Output Current | V _{DDO} ¹ = 5V | -4 | | mA |
| | | V _{DDO} = 3.3V | -2 | | |
| | | V _{DDO} = 2.5V | -1 | | |
| I _{OL} | Low-level Output Current | V _{DDO} = 5V | | 4 | mA |
| | | V _{DDO} = 3.3V | | 2 | |
| | | V _{DDO} = 2.5V | | 1 | |
| V _{IH} | High-level Input Voltage | 2.0 | | | V |
| V _{IL} | Low-level Input Voltage | | | 0.8 | V |
| DR | Data Rate | 0 | | 150 | Mbps |
| T _A | Ambient Temperature | -40 | 27 | 125 | °C |

Note:

- V_{DDO} = Output-side supply V_{DD}.

7.4. Thermal Information

| Thermal Metric | CA-IS376x | | Unit | |
|------------------|--|--------------|------|------|
| | SOIC16-NB(N) | SOIC16-WB(W) | | |
| R _{θJA} | Junction-to-ambient thermal resistance | 96.2 | 83.4 | °C/W |

7.5. Power Rating

| Parameters | | Test conditions | MIN | TYPE | MAX | Unit |
|------------------|-------------------------------------|--|-----|------|-----|------|
| CA-IS3760 | | | | | | |
| P_D | Maximum Power Dissipation | $V_{DDA} = V_{DDB} = 5.5\text{ V}$, $C_L = 15\text{ pF}$, $T_J = 150^\circ\text{C}$, Input a 75-MHz 50% duty cycle square wave. | | | 494 | mW |
| P_{DA} | Maximum Power Dissipation on Side-A | | | | 49 | mW |
| P_{DB} | Maximum Power Dissipation on Side-B | | | | 445 | mW |
| CA-IS3761 | | | | | | |
| P_D | Maximum Power Dissipation | $V_{DDA} = V_{DDB} = 5.5\text{ V}$, $C_L = 15\text{ pF}$, $T_J = 150^\circ\text{C}$, Input a 75-MHz 50% duty cycle square wave. | | | 494 | mW |
| P_{DA} | Maximum Power Dissipation on Side-A | | | | 113 | mW |
| P_{DB} | Maximum Power Dissipation on Side-B | | | | 381 | mW |
| CA-IS3762 | | | | | | |
| P_D | Maximum Power Dissipation | $V_{DDA} = V_{DDB} = 5.5\text{ V}$, $C_L = 15\text{ pF}$, $T_J = 150^\circ\text{C}$, Input a 75-MHz 50% duty cycle square wave. | | | 494 | mW |
| P_{DA} | Maximum Power Dissipation on Side-A | | | | 180 | mW |
| P_{DB} | Maximum Power Dissipation on Side-B | | | | 314 | mW |
| CA-IS3763 | | | | | | |
| P_D | Maximum Power Dissipation | $V_{DDA} = V_{DDB} = 5.5\text{ V}$, $C_L = 15\text{ pF}$, $T_J = 150^\circ\text{C}$, Input a 75-MHz 50% duty cycle square wave. | | | 494 | mW |
| P_{DA} | Maximum Power Dissipation on Side-A | | | | 247 | mW |
| P_{DB} | Maximum Power Dissipation on Side-B | | | | 247 | mW |

7.6. Insulation Specifications

| Parameters | | Test conditions | Value | | Unit |
|--|---|--|-------------------|-------------------|------------------|
| | | | W | N | |
| CLR | External Clearance | Shortest terminal-to-terminal distance through air | 8 | 4 | mm |
| CPG | External Creepage | Shortest terminal-to-terminal distance across the package surface | 8 | 4 | mm |
| DTI | Distance through the insulation | Minimum internal gap (internal clearance) | 28 | 28 | μm |
| CTI | Comparative tracking index | DIN EN 60112 (VDE 0303-11); IEC 60112 | >600 | >600 | V |
| | Material group | Per IEC 60664-1 | I | I | |
| Overvoltage category per IEC 60664-1 | Rated mains voltage ≤ 150 V _{RMS} | | I-IV | I-IV | |
| | Rated mains voltage ≤ 300 V _{RMS} | | I-IV | I-III | |
| | Rated mains voltage ≤ 600 V _{RMS} | | I-IV | n/a | |
| | Rated mains voltage ≤ 1000 V _{RMS} | | I-III | n/a | |
| DIN V VDE V 0884-17:2021-10¹ | | | | | |
| V _{IORM} | Maximum repetitive peak isolation voltage | AC voltage (bipolar) | 1414 | 566 | V _{PK} |
| V _{IOWM} | Maximum operating isolation voltage | AC voltage; time-dependent dielectric breakdown (TDDb) test | 1000 | 400 | V _{RMS} |
| | | DC voltage | 1414 | 566 | V _{DC} |
| V _{IOTM} | Maximum transient isolation voltage | V _{TEST} = V _{IOTM} , t=60 s (certified); V _{TEST} = 1.2 × V _{IOTM} , t=1 s (100% product test) | 7070 | 5300 | V _{PK} |
| V _{IOSM} | Maximum surge isolation voltage ² | Test method per IEC 60065, 1.2/50 μs waveform, V _{TEST} = 1.6 × V _{IOSM} (qualification) (W) V _{TEST} = 1.3 × V _{IOSM} (qualification) (N) | 7070 | 5000 | V _{PK} |
| Q _{pd} | Apparent charge ³ | Method a, after input/output safety test of the subgroup 2/3, V _{ini} = V _{IOTM} , t _{ini} = 60 s; V _{pd(m)} = 1.2 × V _{IORM} , t _m = 10 s | ≤5 | ≤5 | pC |
| | | Method a, after environmental test of the subgroup 1, V _{ini} = V _{IOTM} , t _{ini} = 60 s; V _{pd(m)} = 1.6 × V _{IORM} , t _m = 10 s | ≤5 | ≤5 | |
| | | Method b, at routine test (100% production test) and preconditioning (type test) V _{ini} = 1.2 × V _{IOTM} , t _{ini} = 1 s; V _{pd(m)} = 1.875 × V _{IORM} , t _m = 1 s (W) V _{pd(m)} = 1.5 × V _{IORM} , t _m = 1 s (N) | ≤5 | ≤5 | |
| C _{IO} | Barrier capacitance, input to output ⁴ | V _{IO} = 0.4 × sin(2πft), f = 1 MHz | ~0.5 | ~0.5 | pF |
| R _{IO} | Isolation resistance ⁴ | V _{IO} = 500 V, T _A = 25°C | >10 ¹² | >10 ¹² | Ω |
| | | V _{IO} = 500 V, 100°C ≤ T _A ≤ 125°C | >10 ¹¹ | >10 ¹¹ | |
| | | V _{IO} = 500 V at T _S = 150°C | >10 ⁹ | >10 ⁹ | |
| | Pollution degree | | 2 | 2 | |
| UL 1577 | | | | | |
| V _{ISO} | Maximum withstanding isolation voltage | V _{TEST} = V _{ISO} , t = 60 s (qualification) V _{TEST} = 1.2 × V _{ISO} , t = 1 s (100% production test) | 5000 | 3750 | V _{RMS} |
| Notes: | | | | | |
| 1. This coupler is suitable for “safe electrical insulation” only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits. | | | | | |
| 2. Devices are immersed in oil during surge characterization test. | | | | | |
| 3. The characterization charge is discharging charge (pd) caused by partial discharge. | | | | | |
| 4. Capacitance and resistance are measured with all pins on field-side and logic-side tied together. | | | | | |

7.7. Safety-Related Certifications

| VDE | UL | CQC | TUV |
|---|--|---|--|
| Certified according to DIN VDE V 0884-17:2021-10 | Certified according to UL 1577 Component Recognition Program | Certified according to GB 4943.1-2011 and GB 8898-2011 | Certified according to EN/IEC 61010-1:2010 (3rd Ed) and EN /IEC 62368-1:2014+A11:2017 |
| Maximum transient isolation voltage: 7070V _{pk} (SOIC16-WB) and 5300V _{pk} (SOIC16-NB) Maximum repetitive peak isolation voltage: 1414V _{pk} (SOIC16-WB) and 566V _{pk} (SOIC16-NB) Maximum surge isolation voltage: 7070V _{pk} (SOIC16-WB) and 5000V _{pk} (SOIC16-NB) | SOIC16-NB: 3750 V _{RMS} ; SOIC16-WB: 5000 V _{RMS} | SOIC16-NB: Basic insulation, 400 V _{RMS} maximum working voltage; SOIC16-WB: Reinforced insulation, 1000 V _{RMS} maximum working voltage (Altitude ≤ 5000 m) | 5000 V _{RMS} (SOIC16-WB) insulation and 3750V _{RMS} (SOIC16-NB) insulation per EN/IEC 61010-1:2010 (3rd Ed) and EN /IEC 62368-1:2014+A11:2017, working voltage is up to 1000 V _{RMS} (SOIC16-WB) and 400 V _{RMS} (SOIC16-NB) |
| Certificate number: 40057278 Certificate number: 40052786 | Certificate number : E511334 | Certificate number SOIC16-NB: CQC20001251750 SOIC16-WB: CQC20001251466 | CB Certificate number: JPTUV-111116; DE 2-027880 AK Certificate number: AK 50474784 0001; AK 50474786 0001 |

7.8. Electrical Characteristics
 $V_{DDA} = V_{DDB} = 5\text{ V} \pm 10\%$, $T_A = -40\text{ to }125^\circ\text{C}$ (over recommended operating conditions, unless otherwise specified)

| Parameters | | Test conditions | MIN | TYP | MAX | UNIT |
|---------------|----------------------------------|--|-------------------|-----|-----|-------------------------|
| V_{OH} | High-level Output Voltage | $I_{OH} = -4\text{mA}$; See Figure 8-1 | $V_{DDO}^{1-0.4}$ | 4.8 | | V |
| V_{OL} | Low-level Output Voltage | $I_{OL} = 4\text{mA}$; See Figure 8-1 | | 0.2 | 0.4 | V |
| $V_{IT+(IN)}$ | High-level Input Voltage | | 2 | | | V |
| $V_{IT-(IN)}$ | Low-level Input Voltage | | | | 0.8 | V |
| I_{IH} | High-Level Input Leakage Current | $V_{IH} = V_{DDA}$ at INx or ENx | | | 20 | μA |
| I_{IL} | Low-Level Input Leakage Current | $V_{IL} = 0\text{ V}$ at INx | -20 | | | μA |
| Z_O | Output Impedance ² | | | 50 | | Ω |
| CMTI | Common-mode Transient Immunity | $V_I = V_{DDI}^1$ or 0 V, $V_{CM} = 1200\text{V}$; See Figure 8-3 | 100 | 150 | | $\text{kV}/\mu\text{s}$ |
| C_i | Input Capacitance ³ | $V_I = V_{DD}/2 + 0.4 \times \sin(2\pi ft)$, $f = 1\text{ MHz}$, $V_{DD} = 5\text{ V}$ | | 2 | | pF |

Notes:

- V_{DDI} = Input-side supply V_{DD} , V_{DDO} = Output-side supply V_{DD} .
- The nominal output impedance of each isolator driver is $50\ \Omega \pm 40\%$.
- Measured from pin to Ground.

 $V_{DDA} = V_{DDB} = 3.3\text{ V} \pm 10\%$, $T_A = -40\text{ to }125^\circ\text{C}$ (over recommended operating conditions, unless otherwise specified)

| Parameters | | Test conditions | MIN | TYP | MAX | UNIT |
|---------------|----------------------------------|--|-------------------|-----|-----|-------------------------|
| V_{OH} | High-level Output Voltage | $I_{OH} = -2\text{mA}$; See Figure 8-1 | $V_{DDO}^{1-0.4}$ | 3.1 | | V |
| V_{OL} | Low-level Output Voltage | $I_{OL} = 2\text{mA}$; See Figure 8-1 | | 0.2 | 0.4 | V |
| $V_{IT+(IN)}$ | Input logic High Voltage | | 2 | | | V |
| $V_{IT-(IN)}$ | Input logic Low Voltage | | | | 0.8 | V |
| I_{IH} | High-Level Input Leakage Current | $V_{IH} = V_{DDA}$ at INx or ENx | | | 20 | μA |
| I_{IL} | Low-Level Input Leakage Current | $V_{IL} = 0\text{ V}$ at INx | -20 | | | μA |
| Z_O | Output Impedance ² | | | 50 | | Ω |
| CMTI | Common-mode Transient Immunity | $V_I = V_{DDI}^1$ or 0 V, $V_{CM} = 1200\text{V}$; See Figure 8-3 | 100 | 150 | | $\text{kV}/\mu\text{s}$ |
| C_i | Input Capacitance ³ | $V_I = V_{DD}/2 + 0.4 \times \sin(2\pi ft)$, $f = 1\text{ MHz}$, $V_{DD} = 3.3\text{ V}$ | | 2 | | pF |

Notes:

- V_{DDI} = Input-side supply V_{DD} , V_{DDO} = Output-side supply V_{DD} .
- The nominal output impedance of each isolator driver is $50\ \Omega \pm 40\%$.
- Measured from pin to Ground.

 $V_{DDA} = V_{DDB} = 2.5\text{ V} \pm 10\%$, $T_A = -40\text{ to }125^\circ\text{C}$ (over recommended operating conditions, unless otherwise specified)

| Parameters | | Test conditions | MIN | TYP | MAX | UNIT |
|---------------|----------------------------------|--|-------------------|-----|-----|-------------------------|
| V_{OH} | High-level Output Voltage | $I_{OH} = -1\text{mA}$; See Figure 8-1 | $V_{DDO}^{1-0.4}$ | 2.3 | | V |
| V_{OL} | Low-level Output Voltage | $I_{OL} = 1\text{mA}$; See Figure 8-1 | | 0.2 | 0.4 | V |
| $V_{IT+(IN)}$ | Input logic High Voltage | | 2 | | | V |
| $V_{IT-(IN)}$ | Input logic Low Voltage | | | | 0.8 | V |
| I_{IH} | High-Level Input Leakage Current | $V_{IH} = V_{DDA}$ at INx or ENx | | | 20 | μA |
| I_{IL} | Low-Level Input Leakage Current | $V_{IL} = 0\text{ V}$ at INx | -20 | | | μA |
| Z_O | Output Impedance ² | | | 50 | | Ω |
| CMTI | Common-mode Transient Immunity | $V_I = V_{DDI}^1$ or 0 V, $V_{CM} = 1200\text{V}$; See Figure 8-3 | 100 | 150 | | $\text{kV}/\mu\text{s}$ |
| C_i | Input Capacitance ³ | $V_I = V_{DD}/2 + 0.4 \times \sin(2\pi ft)$, $f = 1\text{ MHz}$, $V_{DD} = 2.5\text{ V}$ | | 2 | | pF |

Notes:

- V_{DDI} = Input-side supply V_{DD} , V_{DDO} = Output-side supply V_{DD} .
- The nominal output impedance of each isolator driver is $50\ \Omega \pm 40\%$.
- Measured from pin to Ground.

7.9. Supply Current Characteristics
 $V_{DDA} = V_{DDB} = 5\text{ V} \pm 10\%$, $T_A = -40$ to 125°C (over recommended operating conditions, unless otherwise specified).

| Parameters | Test conditions | SUPPLY CURRENT | MIN | TYP | MAX | UNIT |
|---|--|-----------------|-----------|------|------|------|
| CA-IS3760 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3760L); $V_{IN} = V_{DDA}$ (CA-IS3760H) | I_{DDA} | | 2.3 | 3.6 | mA |
| | | I_{DDB} | | 4.0 | 6.3 | |
| | $V_{IN} = V_{DDA}$ (CA-IS3760L); $V_{IN} = 0\text{V}$ (CA-IS3760H) | I_{DDA} | | 10 | 16 | |
| | | I_{DDB} | | 4.0 | 6.3 | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 6.2 | 9.9 | |
| | | | I_{DDB} | 4.5 | 7.2 | |
| | | 10Mbps (5MHz) | I_{DDA} | 6.3 | 10 | |
| | | | I_{DDB} | 8.3 | 12.8 | |
| | | 100Mbps (50MHz) | I_{DDA} | 8.4 | 13.5 | |
| | | | I_{DDB} | 46 | 70.5 | |
| CA-IS3761 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3761L); $V_{IN} = V_{DDI}^1$ (CA-IS3761H) | I_{DDA} | | 2.9 | 4.6 | mA |
| | | I_{DDB} | | 4.3 | 6.8 | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3761L); $V_{IN} = 0\text{V}$ (CA-IS3761H) | I_{DDA} | | 9.6 | 15.3 | |
| | | I_{DDB} | | 5.8 | 9.2 | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 6.3 | 10 | |
| | | | I_{DDB} | 5.4 | 8.5 | |
| | | 10Mbps (5MHz) | I_{DDA} | 7.1 | 11.2 | |
| | | | I_{DDB} | 8.8 | 13.5 | |
| | | 100Mbps (50MHz) | I_{DDA} | 16 | 25 | |
| | | | I_{DDB} | 41.4 | 62.8 | |
| CA-IS3762 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3762L); $V_{IN} = V_{DDI}^1$ (CA-IS3762H) | I_{DDA} | | 3.6 | 5.7 | mA |
| | | I_{DDB} | | 3.9 | 6.2 | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3762L); $V_{IN} = 0\text{V}$ (CA-IS3762H) | I_{DDA} | | 8.7 | 13.9 | |
| | | I_{DDB} | | 6.5 | 10.4 | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 6.3 | 10 | |
| | | | I_{DDB} | 5.5 | 8.7 | |
| | | 10Mbps (5MHz) | I_{DDA} | 7.6 | 11.9 | |
| | | | I_{DDB} | 8.2 | 12.9 | |
| | | 100Mbps (50MHz) | I_{DDA} | 21.3 | 32.6 | |
| | | | I_{DDB} | 34.4 | 52.5 | |
| CA-IS3763 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3763L); $V_{IN} = V_{DDI}^1$ (CA-IS3763H) | I_{DDA} | | 3.2 | 5.1 | mA |
| | | I_{DDB} | | 3.2 | 5.1 | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3763L); $V_{IN} = 0\text{V}$ (CA-IS3763H) | I_{DDA} | | 7.1 | 11.4 | |
| | | I_{DDB} | | 7.1 | 11.4 | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 5.4 | 8.6 | |
| | | | I_{DDB} | 5.4 | 8.6 | |
| | | 10Mbps (5MHz) | I_{DDA} | 7.4 | 11.6 | |
| | | | I_{DDB} | 7.4 | 11.6 | |
| | | 100Mbps (50MHz) | I_{DDA} | 27.7 | 42.2 | |
| | | | I_{DDB} | 27.7 | 42.2 | |
| Note: | | | | | | |
| 1. V_{DDI}^1 = Input-side supply V_{DD} . | | | | | | |

$V_{DDA} = V_{DDB} = 3.3\text{ V} \pm 10\%$, $T_A = -40\text{ to }125^\circ\text{C}$ (over recommended operating conditions, unless otherwise specified)

| Parameters | Test conditions | SUPPLY CURRENT | MIN | TYP | MAX | UNIT |
|---|--|-----------------|-----------|------|------|------|
| CA-IS3760 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3760L); $V_{IN} = V_{DDA}$ (CA-IS3760H) | I_{DDA} | 2.2 | 3.5 | mA | |
| | | I_{DDB} | 3.8 | 6.0 | | |
| | $V_{IN} = V_{DDA}$ (CA-IS3760L); $V_{IN} = 0\text{V}$ (CA-IS3760H) | I_{DDA} | 10.0 | 16.0 | | |
| | | I_{DDB} | 4.0 | 6.3 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 3.3V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 6.1 | | 9.8 |
| | | | I_{DDB} | 4.2 | | 6.6 |
| | | 10Mbps (5MHz) | I_{DDA} | 6.1 | | 9.7 |
| | | | I_{DDB} | 6.8 | | 10.5 |
| | | 100Mbps (50MHz) | I_{DDA} | 7.4 | 11.8 | |
| | | | I_{DDB} | 32.0 | 48.9 | |
| CA-IS3761 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3761L); $V_{IN} = V_{DDI}^1$ (CA-IS3761H) | I_{DDA} | 2.8 | 4.4 | mA | |
| | | I_{DDB} | 4.1 | 6.5 | | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3761L); $V_{IN} = 0\text{V}$ (CA-IS3761H) | I_{DDA} | 9.4 | 15.0 | | |
| | | I_{DDB} | 5.6 | 8.9 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 3.3V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 6.2 | | 9.9 |
| | | | I_{DDB} | 5.1 | | 8.2 |
| | | 10Mbps (5MHz) | I_{DDA} | 6.6 | | 10.4 |
| | | | I_{DDB} | 7.4 | | 11.5 |
| | | 100Mbps (50MHz) | I_{DDA} | 12.5 | 19.4 | |
| | | | I_{DDB} | 29.7 | 45.1 | |
| CA-IS3762 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3762L); $V_{IN} = V_{DDI}^1$ (CA-IS3762H) | I_{DDA} | 3.4 | 5.4 | mA | |
| | | I_{DDB} | 3.7 | 5.8 | | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3762L); $V_{IN} = 0\text{V}$ (CA-IS3762H) | I_{DDA} | 8.5 | 13.5 | | |
| | | I_{DDB} | 6.3 | 10.0 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 3.3V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 6.1 | | 9.7 |
| | | | I_{DDB} | 5.2 | | 8.2 |
| | | 10Mbps (5MHz) | I_{DDA} | 7.0 | | 11.0 |
| | | | I_{DDB} | 7.0 | | 10.9 |
| | | 100Mbps (50MHz) | I_{DDA} | 16.4 | 25.2 | |
| | | | I_{DDB} | 24.7 | 37.8 | |
| CA-IS3763 | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3763L); $V_{IN} = V_{DDI}^1$ (CA-IS3763H) | I_{DDA} | 3.0 | 4.7 | mA | |
| | | I_{DDB} | 3.0 | 4.7 | | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3763L); $V_{IN} = 0\text{V}$ (CA-IS3763H) | I_{DDA} | 7.0 | 11.2 | | |
| | | I_{DDB} | 7.0 | 11.2 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 3.3V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | 5.1 | | 8.1 |
| | | | I_{DDB} | 5.1 | | 8.1 |
| | | 10Mbps (5MHz) | I_{DDA} | 6.5 | | 10.2 |
| | | | I_{DDB} | 6.5 | | 10.2 |
| | | 100Mbps (50MHz) | I_{DDA} | 20.1 | 30.7 | |
| | | | I_{DDB} | 20.1 | 30.7 | |
| Note: | | | | | | |
| 1. V_{DDI}^1 = Input-side supply V_{DD} . | | | | | | |

$V_{DDA} = V_{DDB} = 2.5\text{ V} \pm 10\%$, $T_A = -40\text{ to }125^\circ\text{C}$ (over recommended operating conditions, unless otherwise specified)

| Parameters | Test conditions | SUPPLY CURRENT | MIN | TYP | MAX | UNIT | |
|---|--|-----------------|-----------|-----|------|------|------|
| CA-IS3760 | | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3760L); $V_{IN} = V_{DDA}$ (CA-IS3760H) | I_{DDA} | | 1.9 | 2.7 | mA | |
| | | I_{DDB} | | 3.6 | 5.2 | | |
| | $V_{IN} = V_{DDA}$ (CA-IS3760L); $V_{IN} = 0\text{V}$ (CA-IS3760H) | I_{DDA} | | 6.8 | 10.4 | | |
| | | I_{DDB} | | 3.8 | 5.5 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 2.5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | | 4.3 | | 6.6 |
| | | | I_{DDB} | | 4.8 | | 6.9 |
| | | 10Mbps (5MHz) | I_{DDA} | | 4.6 | | 6.9 |
| | | | I_{DDB} | | 14.7 | | 19.8 |
| | | 100Mbps (50MHz) | I_{DDA} | | 5.7 | 8.5 | |
| | | | I_{DDB} | | 28.9 | 39.0 | |
| CA-IS3761 | | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3761L); $V_{IN} = V_{DDI}^1$ (CA-IS3761H) | I_{DDA} | | 2.1 | 3.2 | mA | |
| | | I_{DDB} | | 3.3 | 4.8 | | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3761L); $V_{IN} = 0\text{V}$ (CA-IS3761H) | I_{DDA} | | 6.3 | 9.6 | | |
| | | I_{DDB} | | 4.3 | 6.4 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 2.5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | | 4.3 | | 6.4 |
| | | | I_{DDB} | | 4.5 | | 6.6 |
| | | 10Mbps (5MHz) | I_{DDA} | | 4.6 | | 6.9 |
| | | | I_{DDB} | | 11.4 | | 15.5 |
| | | 100Mbps (50MHz) | I_{DDA} | | 7.6 | 10.8 | |
| | | | I_{DDB} | | 23.1 | 31.2 | |
| CA-IS3762 | | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3762L); $V_{IN} = V_{DDI}^1$ (CA-IS3762H) | I_{DDA} | | 2.6 | 4.2 | mA | |
| | | I_{DDB} | | 3.5 | 5.5 | | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3762L); $V_{IN} = 0\text{V}$ (CA-IS3762H) | I_{DDA} | | 6.0 | 9.6 | | |
| | | I_{DDB} | | 5.3 | 8.3 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 2.5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | | 4.8 | | 7.4 |
| | | | I_{DDB} | | 5.2 | | 8.0 |
| | | 10Mbps (5MHz) | I_{DDA} | | 8.6 | | 12.4 |
| | | | I_{DDB} | | 12.6 | | 18.6 |
| | | 100Mbps (50MHz) | I_{DDA} | | 14.8 | 21.2 | |
| | | | I_{DDB} | | 23.3 | 36.3 | |
| CA-IS3763 | | | | | | | |
| Supply Current – DC Signal | $V_{IN} = 0\text{V}$ (CA-IS3763L); $V_{IN} = V_{DDI}^1$ (CA-IS3763H) | I_{DDA} | | 2.7 | 4.0 | mA | |
| | | I_{DDB} | | 2.7 | 4.0 | | |
| | $V_{IN} = V_{DDI}^1$ (CA-IS3763L); $V_{IN} = 0\text{V}$ (CA-IS3763H) | I_{DDA} | | 5.2 | 8.0 | | |
| | | I_{DDB} | | 5.2 | 8.0 | | |
| Supply Current – AC Signal | All Channels Switching with 50% Duty Cycle Square Wave Clock Input with 2.5V Amplitude; $C_L = 15\text{ pF}$ for Each Channel. | 1Mbps (500kHz) | I_{DDA} | | 4.0 | | 6.1 |
| | | | I_{DDB} | | 4.0 | | 6.1 |
| | | 10Mbps (5MHz) | I_{DDA} | | 4.8 | | 7.0 |
| | | | I_{DDB} | | 4.8 | | 7.0 |
| | | 100Mbps (50MHz) | I_{DDA} | | 11.3 | 16.0 | |
| | | | I_{DDB} | | 11.3 | 16.0 | |
| Note: | | | | | | | |
| 1. $V_{DDI} = \text{Input-side supply } V_{DD}$. | | | | | | | |

7.10. Timing Characteristics
 $V_{DDA} = V_{DDB} = 5\text{ V} \pm 10\%$, $T_A = -40$ to 125°C (over recommended operating conditions, unless otherwise specified)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|-------------------------|-----|------|------|---------------|
| DR Data Rate | | 0 | | 150 | Mbps |
| PW_{\min} Minimum Pulse Width | | | | 5.0 | ns |
| t_{PLH} , t_{PHL} Propagation Delay Time | See Figure 8- 1 | 5.0 | 12.0 | 15.0 | ns |
| PWD Pulse Width Distortion $ t_{PLH} - t_{PHL} $ | | | | | |
| $t_{sk(o)}$ Channel-to-Channel Output Skew Time ¹ | Same-direction channels | | 0.4 | 2.5 | ns |
| $t_{sk(pp)}$ Part-to-Part Output Skew Time ² | | | 2.0 | 4.5 | ns |
| t_r Output Signal Rise Time | See Figure 8- 1 | | 2.5 | 4.0 | ns |
| t_f Output Signal Fall Time | See Figure 8- 1 | | 2.5 | 4.0 | ns |
| t_{DO} Default Output Delay Time from Input Power Loss | See Figure 8- 1 | | 8 | 12 | μs |
| t_{SU} Start-up Time | | | 15 | 40 | μs |

Notes:

1. $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
2. $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

 $V_{DDA} = V_{DDB} = 3.3\text{ V} \pm 10\%$, $T_A = -40$ to 125°C (over recommended operating conditions, unless otherwise specified)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|-------------------------|-----|------|------|---------------|
| DR Data Rate | | 0 | | 150 | Mbps |
| PW_{\min} Minimum Pulse Width | | | | 5.0 | ns |
| t_{PLH} , t_{PHL} Propagation Delay Time | See Figure 8- 1 | 5.0 | 12.0 | 15.0 | ns |
| PWD Pulse Width Distortion $ t_{PLH} - t_{PHL} $ | | | | | |
| $t_{sk(o)}$ Channel-to-Channel Output Skew Time ¹ | Same-direction channels | | 0.4 | 2.5 | ns |
| $t_{sk(pp)}$ Part-to-Part Output Skew Time ² | | | 2.0 | 4.5 | ns |
| t_r Output Signal Rise Time | See Figure 8- 1 | | 2.5 | 4.0 | ns |
| t_f Output Signal Fall Time | See Figure 8- 1 | | 2.5 | 4.0 | ns |
| t_{DO} Default Output Delay Time from Input Power Loss | See Figure 8- 1 | | 8 | 12 | μs |
| t_{SU} Start-up Time | | | 15 | 40 | μs |

Notes:

1. $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
2. $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

 $V_{DDA} = V_{DDB} = 2.5\text{ V} \pm 10\%$, $T_A = -40$ to 125°C (over recommended operating conditions, unless otherwise specified)

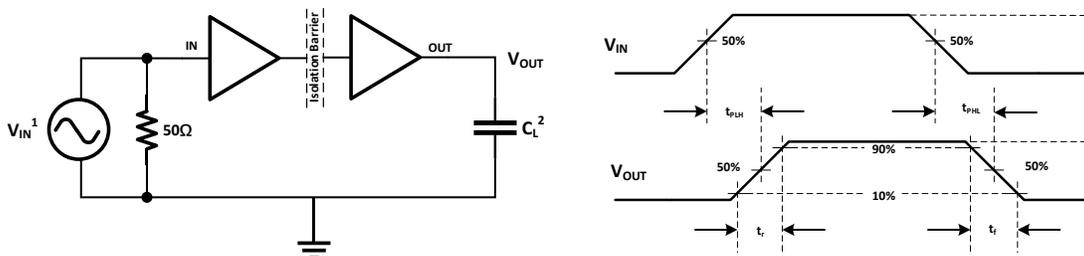
| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|-------------------------|-----|------|------|---------------|
| DR Data Rate | | 0 | | 150 | Mbps |
| PW_{\min} Minimum Pulse Width | | | | 5.0 | ns |
| t_{PLH} , t_{PHL} Propagation Delay Time | See Figure 8- 1 | 5.0 | 12.0 | 15.0 | ns |
| PWD Pulse Width Distortion $ t_{PLH} - t_{PHL} $ | | | | | |
| $t_{sk(o)}$ Channel-to-Channel Output Skew Time ¹ | Same-direction channels | | 0.4 | 2.5 | ns |
| $t_{sk(pp)}$ Part-to-Part Output Skew Time ² | | | 1.0 | 5.0 | ns |
| t_r Output Signal Rise Time | See Figure 8-1 | | 2.5 | 4.0 | ns |
| t_f Output Signal Fall Time | See Figure 8- 1 | | 2.5 | 4.0 | ns |
| t_{DO} Default Output Delay Time from Input Power Loss | See Figure 8- 1 | | 8 | 12 | μs |
| t_{SU} Start-up Time | | | 15 | 40 | μs |

Notes:

1. $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

2. $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

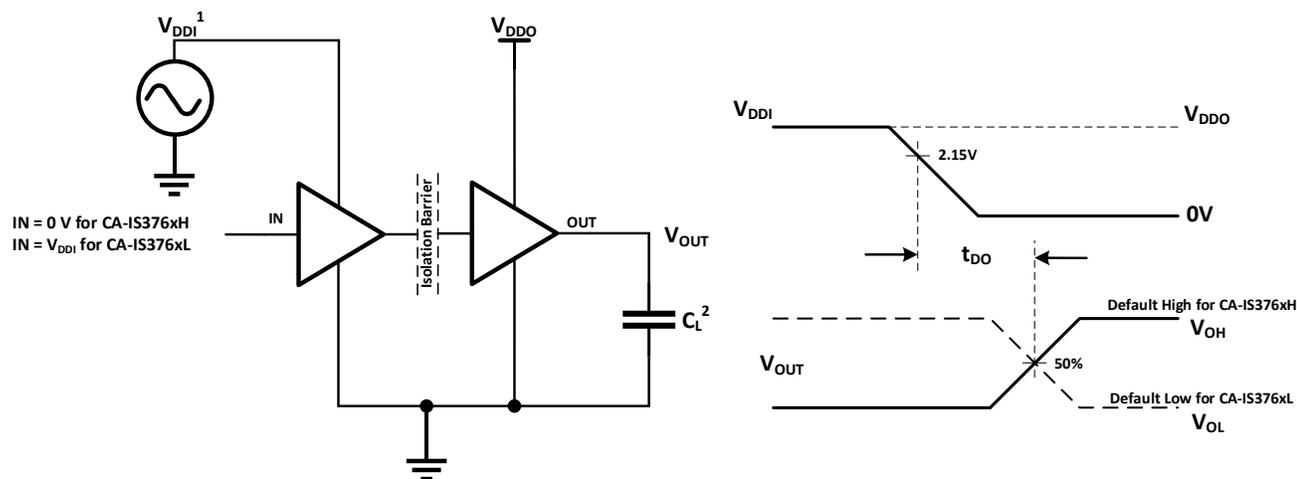
8. Parameter Measurement Information



Notes:

1. A square wave generator provide V_{IN} input signal with the following characteristics: frequency $\leq 100\text{kHz}$, 50% duty cycle, $t_r \leq 3\text{ns}$, $t_f \leq 3\text{ns}$, $Z_{out} = 50\Omega$. At the input, 50Ω resistor is required to terminate input generator signal. It is not needed in actual application.
2. $C_L = 15\text{pF}$ and includes external circuit (instrumentation and fixture etc.) capacitance. Since the load capacitance influence the output rising time, it's a key factor in the timing characteristic measurement.

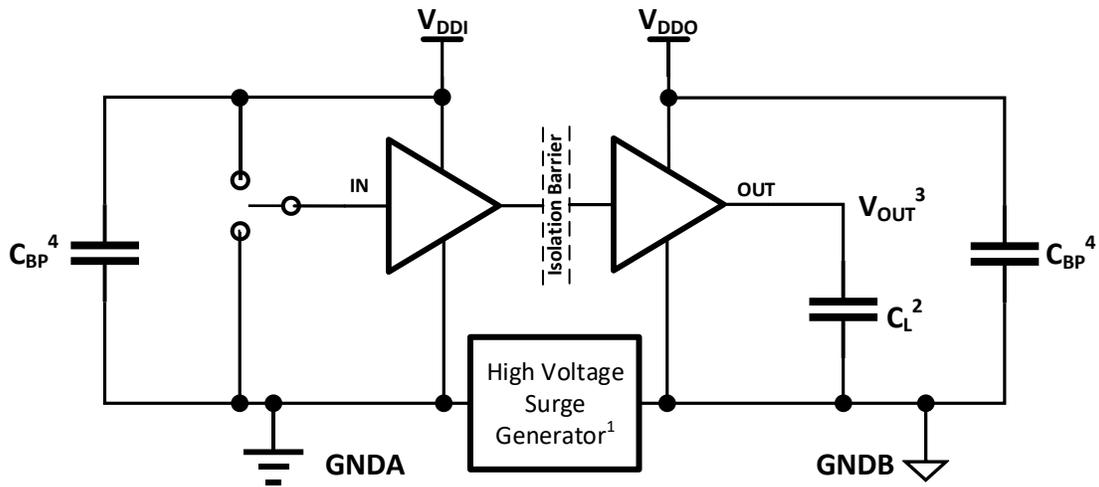
Figure 8- 1 Switching Characteristics Test Circuit and Voltage Waveforms



Notes:

1. Power Supply Ramp Rate = 10 mV/ns . V_{DDI} should ramp over 2.375V , and less than 5.5V .
2. $C_L = 15\text{pF}$ and includes external circuit (instrumentation and fixture etc.) capacitance. Since the load capacitance influence the output rising time, it's a key factor in the timing characteristic measurement.

Figure 8- 2 Default Output Delay Time Test Circuit and Voltage Waveforms



Notes:

1. The High Voltage Surge Generator generates repetitive high voltage surges with > 1kV amplitude, rise time <10ns and fall time <10ns, to reach common-mode transient noise with > 150kV/μs slew rate.
2. $C_L = 15\text{pF}$ and includes external circuit (instrumentation and fixture etc.) capacitance.
3. Pass-fail criteria: the output must remain stable.
4. C_{BP} (0.1 ~ 1μF) is bypass capacitance.

Figure 8- 3 Common-Mode Transient Immunity Test Circuit

9. Detailed Description

9.1. Overview

The CA-IS376x are a family of six-channel digital galvanic isolators using Chipanalog’s full differential capacitive isolation technology. These devices have an ON-OFF keying (OOK) modulation scheme to transfer digital signals across the SiO₂ based isolation barrier between circuits with different power domains. The transmitter sends a high frequency carrier across the barrier to represent one digital state and sends no signal to represent the other digital state. The receiver demodulates the signal and recovery input signal at output through a buffer stage. With this OOK architecture, CA-IS376x family of devices build a robust data transmission path between different power domains without any special start-up initialization requirements. These devices also incorporate advanced full differential techniques to maximize the CMTI performance and minimize the radiated emissions due the high frequency carrier and IO buffer switching.

9.2. Functional Block Diagram

The conceptual block diagram of a digital capacitive isolator, Figure 9-1 shows a functional block diagram of a typical channel; Figure 9-2 shows the operating waveform of a typical channel. Each channel of the CA-IS376x is unidirectional, only passes data in one direction as indicated in the functional diagram. Each device of this family features six unidirectional channels that operate independently with guaranteed data rates from DC up to 150Mbps.

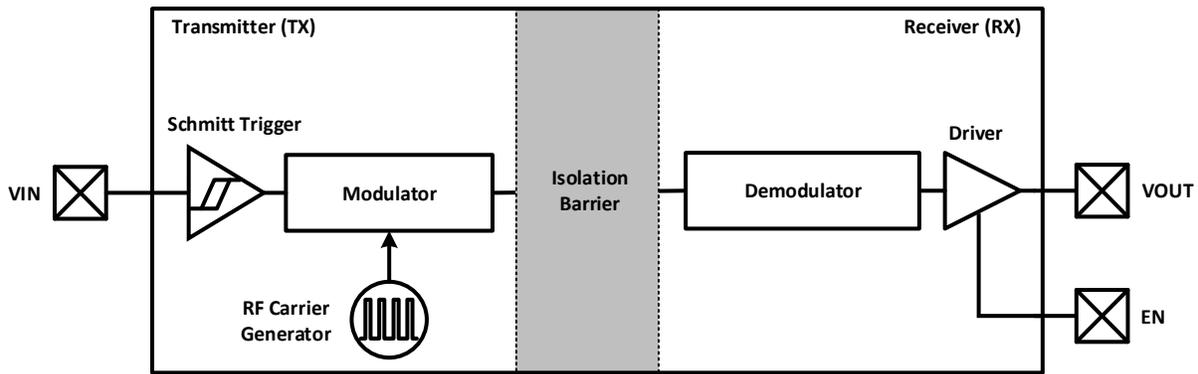


Figure 9- 1 Functional Block Diagram of a Single Channel

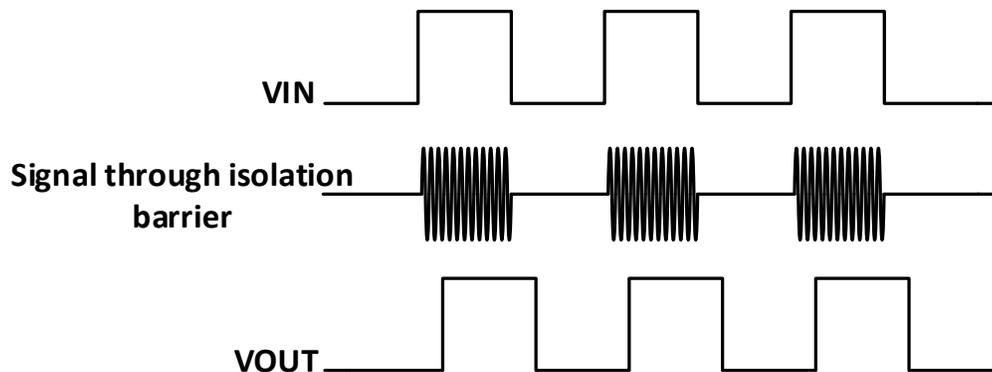


Figure 9- 2 Conceptual Operation Waveforms of a Single Channel

9.3. Device Operation Modes

Table 9-1 lists the operation modes for the CA-IS376x devices.

Table 9-1. Operation Mode

| V_{DDI}^1 | V_{DDO}^1 | INPUT (VIx) ² | OUTPUT (VOx) | OPERATION |
|-------------|-------------|--------------------------|--------------|--|
| PU | PU | H | H | Normal operation mode: A channel output follows the logic state of its input. |
| | | L | L | |
| | | Open | Default | Default output mode: When input VIx is open, the corresponding channel output goes to its default logic state. Default is <i>High</i> for CA-IS376xH and Low for CA-IS376xL. |
| PD | PU | X | Default | Default output mode: When V_{DDI} is unpowered, a channel output assumes the logic state based on its default option. Default is <i>High</i> for CA-IS376xH and Low for CA-IS376xL. |
| X | PD | X | Undetermined | If the output side V_{DDO} is unpowered, a channel output is undetermined. ⁴ |

Notes:

- V_{DDI} = Input-side supply V_{DD} ; V_{DDO} = Output-side supply V_{DD} ; PU = Powered up ($V_{DD} \geq V_{DD(UVLO+)}$); PD = Powered down ($V_{DD} \leq V_{DD(UVLO-)}$); X = Irrelevant; H = High level; L = Low level; Z = High Impedance.
- A strongly driven input signal can weakly power the floating V_{DD} through an internal protection diode and cause undetermined output.
- It is recommended to connect the enable inputs to external logic high or low level when the CA-IS376x operates in noisy environments.
- The outputs are in undetermined state when $V_{DD(UVLO-)} < V_{DDI}$, $V_{DDO} < V_{DD(UVLO+)}$.

10. Application and Implementation

The CA-IS376x isolation ICs provide complete galvanic isolation between two power domains, protecting circuits from high common-mode transients and faults, eliminating ground loops. In many applications, digital isolators are replacing optocouplers because they can reduce the power requirements and take up less board space while offering the same isolation capability. The CA-IS376x devices are the high-performance, six-channel digital isolators. Unlike optocouplers, which require external components to improve performance, provide bias, or limit current, the CA-IS376x devices only require two external bypass capacitors to operate. To reduce ripple and the chance of introducing data errors, bypass V_{DDA} and V_{DDB} pins with 0.1 μ F to 1 μ F low-ESR ceramic capacitors to $GNDA$ and $GNDB$ respectively. Place the bypass capacitors as close to the power supply input pins as possible. Figure 10-1 shows typical operating circuit of the CA-IS3763; Figure 10-2 is the typical applications for CA-IS37xx series products.

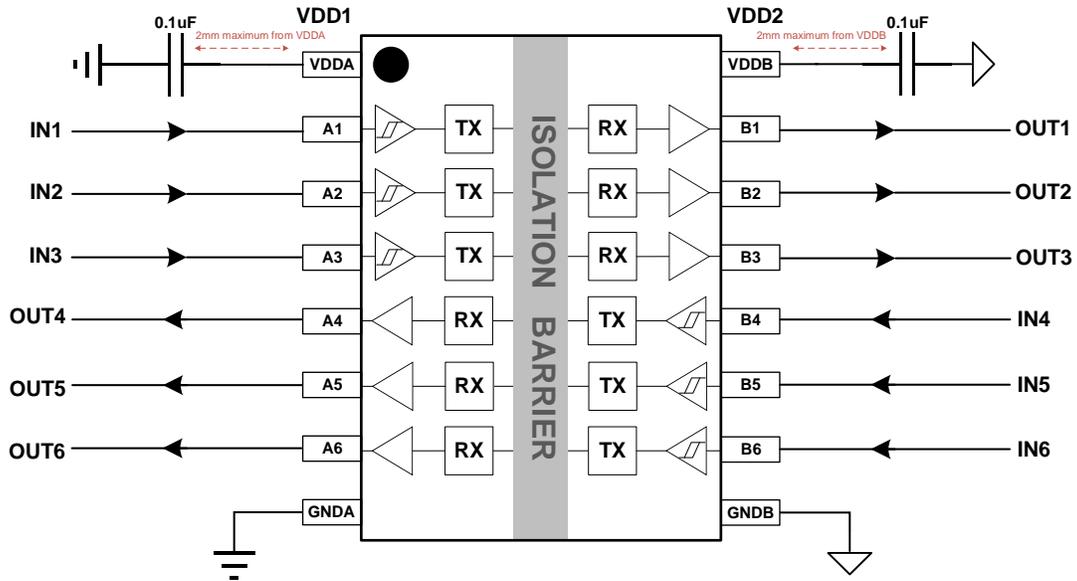


Figure 10- 1 Typical Application Circuit of CA-IS3763

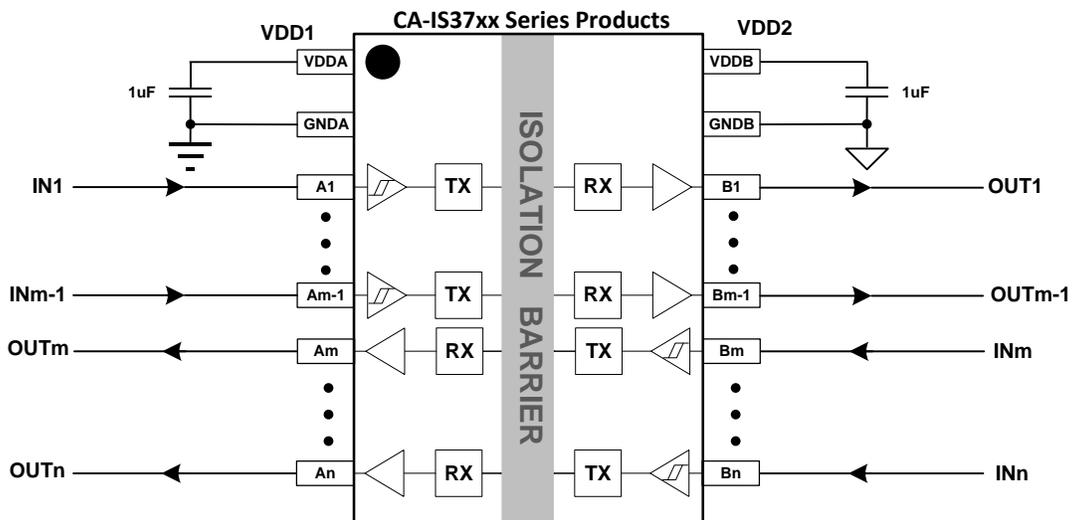
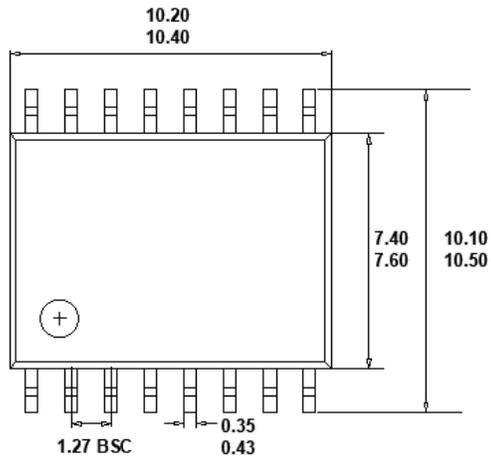


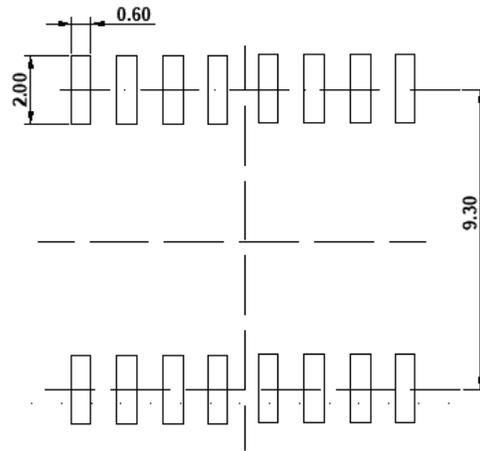
Figure 10- 2 Typical Applications for the CA-IS37xx Series Digital Isolators

11. Package Information

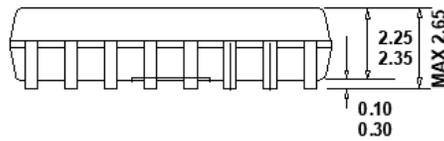
11.1. 16-Pin Wide Body SOIC Package Outline



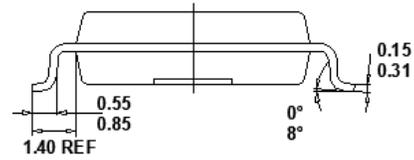
TOP VIEW



RECOMMENDED LAND PATTERN



FRONT VIEW

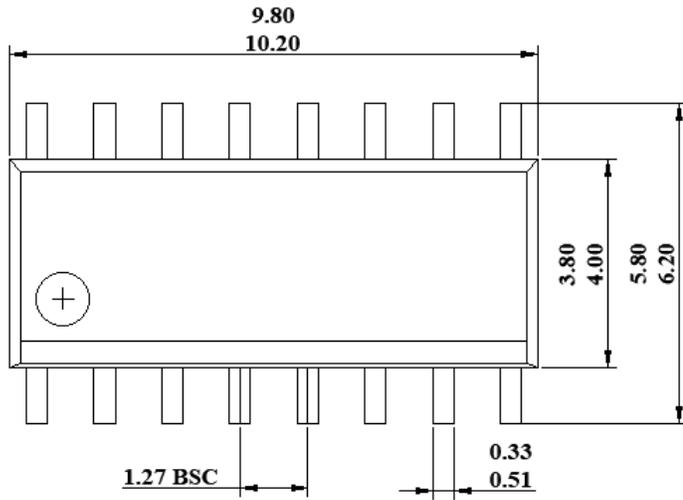


LEFT SIDE VIEW

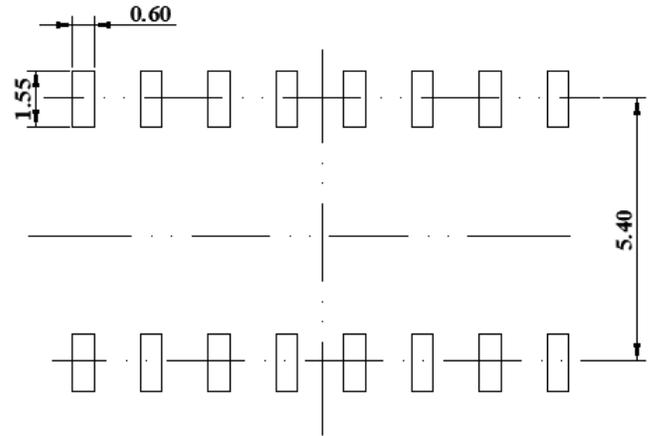
Note:

1. All dimensions are in millimeters, angles are in degrees.

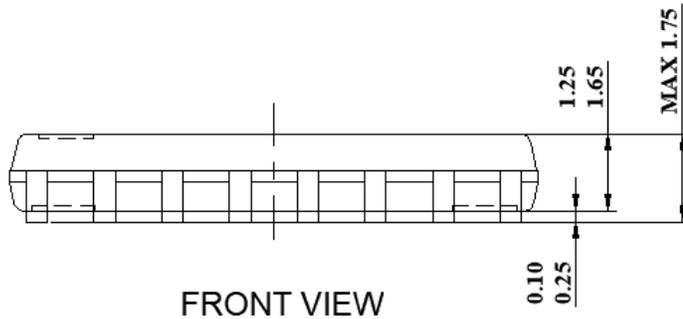
11.2. 16-Pin Narrow Body SOIC Package Outline



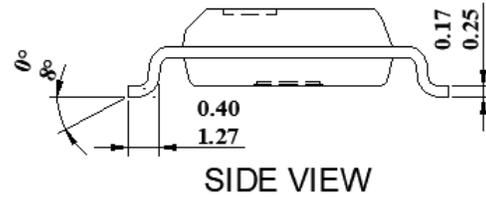
TOP VIEW



RECOMMENDED LAND PATTERN



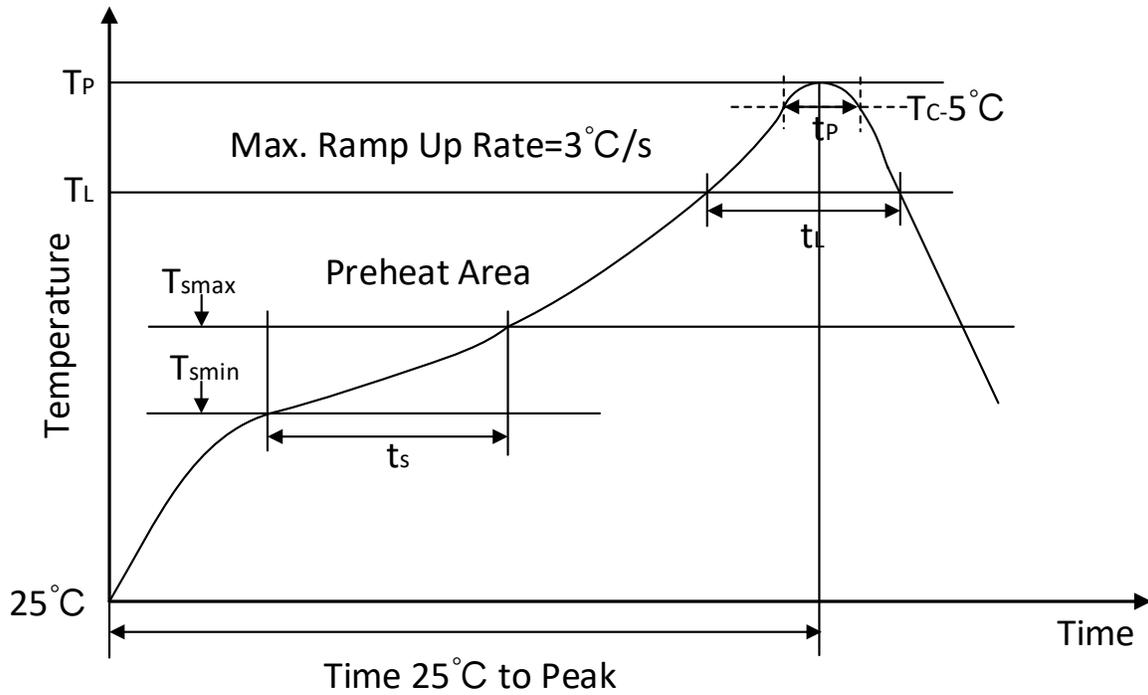
FRONT VIEW



SIDE VIEW

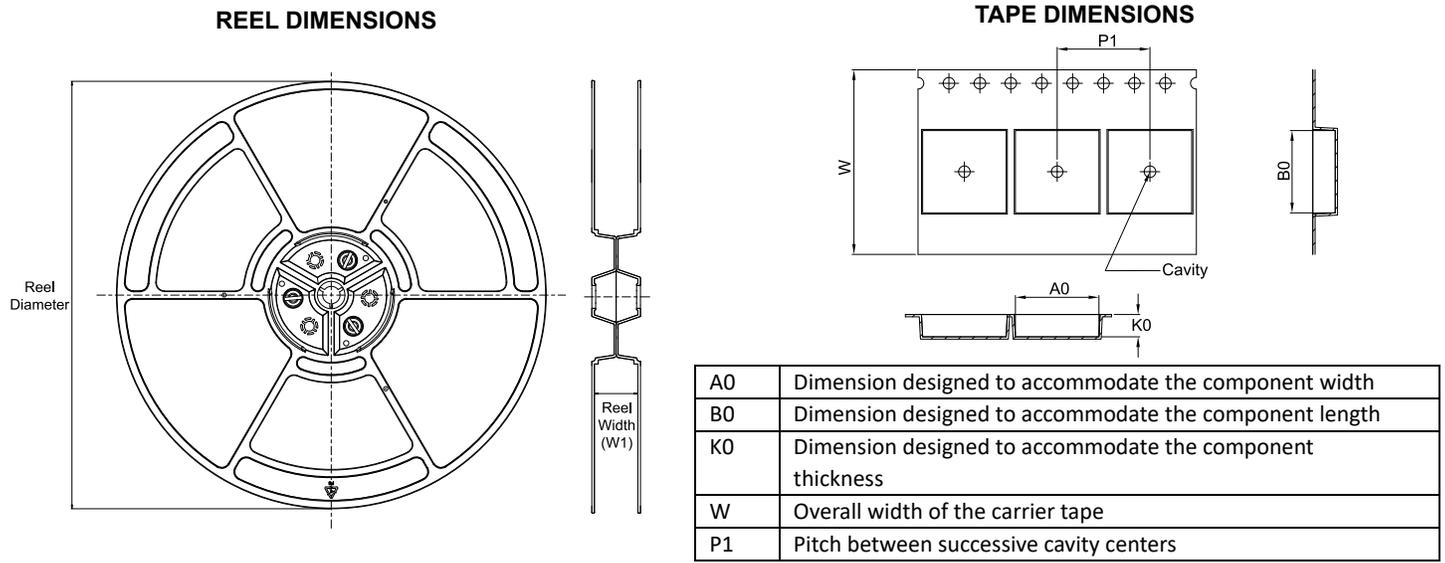
Note:

1. All dimensions are in millimeters, angles are in degrees.

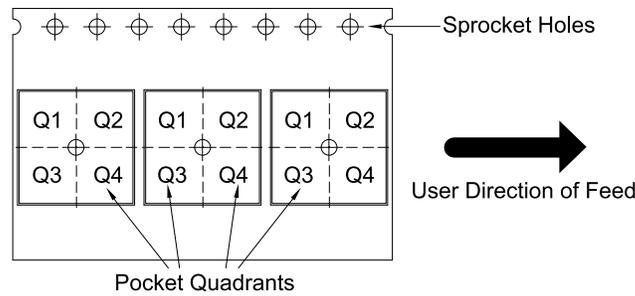
12. Soldering Temperature (reflow) Profile

Figure 12- 1 Soldering Temperature (reflow) Profile
Table 12- 1 Soldering Temperature Parameter

| Profile Feature | Pb-Free Assembly |
|--|------------------|
| Average ramp-up rate(217 °C to Peak) | 3°C /second max |
| Time of Preheat temp(from 150 °C to 200 °C) | 60-120 second |
| Peak temperature | 260 +5/-0 °C |
| Time to be maintained above 217 °C | 60-150 second |
| Time within 5 °C of actual peak temp | 30 second |
| Ramp-down rate | 6 °C/second max. |
| Time from 25°C to peak temp | 8 minutes max |

13. Tape and Reel Information



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| CA-IS3760LN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3760LW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3760HN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3760HW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3761LN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3761LW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3761HN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3761HW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3762LN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3762LW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3762HN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3762HW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3763LN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3763LW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |
| CA-IS3763HN | SOIC | N | 16 | 2500 | 330 | 16.4 | 6.40 | 10.30 | 2.10 | 8.00 | 16.00 | Q1 |
| CA-IS3763HW | SOIC | W | 16 | 1000 | 330 | 16.4 | 10.90 | 10.70 | 3.20 | 12.00 | 16.00 | Q1 |

14. Important statement

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